
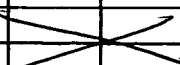



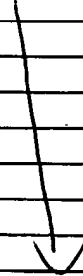
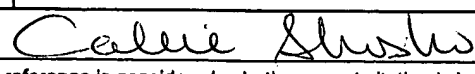
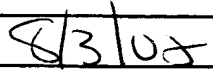


Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 244329US0		SERIAL NO. New Application	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Shin HASEGAWA, et al.			
				FILING DATE Herewith		GROUP	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE	
	AA	6,565,642	05/20/2003	Keishi TANIGUCHI, et al.			
	AB	6,063,835	05/16/2000	Kouichi. OHSHIMA, et al.			
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO	56-147863	11/17/81	JAPAN (with English Abstract)		X	
	AP	61-83267	04/26/86	JAPAN (with English Abstract)		X	
	AQ	5-105837	04/27/93	JAPAN (with English Abstract)		X	
	AR	10-168367	06/23/98	JAPAN (with English Abstract)		X	
	AS	10-88050	04/07/98	JAPAN (with English Abstract)		X	
	AT	8-244254	09/24/96	JAPAN (with English Abstract)		X	
	AU	10-44473	02/17/98	JAPAN (with English Abstract)		X	
	AV	2001-192583	07/17/2001	JAPAN (with English Abstract)		X	
	AW	WO 99/05230	02/04/99	WIPO (with partial English translation)			
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AX						
	AY						
	AZ						
						<input type="checkbox"/> Additional References sheet(s) attached	
Examiner 				Date Considered 			
<small>*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							



SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 244329US0		SERIAL NO. 10/694,043	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Shin HASEGAWA, et al.			
				FILING DATE October 28, 2003		GROUP 1755	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
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	AG						
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	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
CS	AO	1 041 126	10/04/2000	EUROPE			
↓	AP	0 767 225	04/09/1997	EUROPE			
	AQ	0 933 406	08/04/1999	EUROPE			
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
CS	AW	Derwent Publications, XP-002264702, JP 7-305006, November 21, 1995					
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner <i>Calvin Shusho</i>					Date Considered 8/3/05		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							